

<b>Notice of References Cited</b>	Application/Control No. 09/600,936	Applicant(s)/Patent Under Reexamination NAKAMURA ET AL.	
	Examiner Patrick L Edwards	Art Unit 2621	Page 1 of 1

**U.S. PATENT DOCUMENTS**

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
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*	B	US-5,982,926	11-1999	Kuo et al.	382/167
*	C	US-6,035,061	03-2000	Katsuyama et al.	382/177
*	D	US-6,266,439	07-2001	Pollard et al.	382/164
*	E	US-6,240,206	05-2001	Tokuyama et al.	382/176
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	M	US-			

**FOREIGN PATENT DOCUMENTS**

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**NON-PATENT DOCUMENTS**

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)
*	U	"Selective Image Sharpening", Image Analysis Handbook. University of Tokyo Press January 17 1991, page 549
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\*A copy of this reference is not being furnished with this Office action. (See MPEP § 707.05(a).)  
Dates in MM-YYYY format are publication dates. Classifications may be US or foreign.